# MSKSEMI 美森科













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# NTTFS5826NL-MS

Product specification





#### Description

The NTTFS5826NL-MS uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

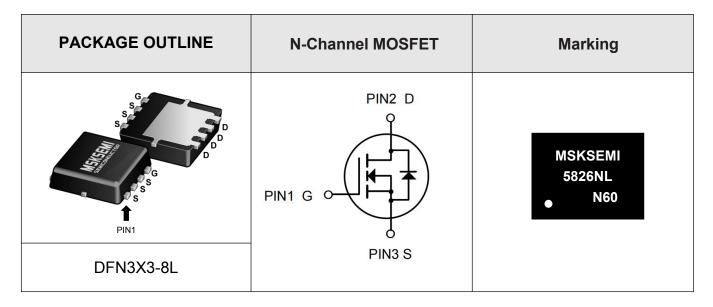
#### Features

- VDS = 60V ID =20 A
- RDS(ON) < 40mΩ @ VGS=10V

## Application

- Battery protection
- Load switch
- Uninterruptible power supply

#### **Reference News**



## Absolute Maximum Ratings (TC=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	Drain-Source Voltage 60	
Vgs	Gate-Source Voltage	tage ±20 V	
lo@Ta=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> 20	
lo@Ta=70°C	Continuous Drain Current, $V_{GS}$ @ $10V^1$	10	А
Ідм	Pulsed Drain Current <sup>2</sup>	46	А
EAS	Single Pulse Avalanche Energy <sup>3</sup> 25.5		mJ
las	Avalanche Current	20	А
Pp@Tc=25°C	Total Power Dissipation <sup>4</sup>	34.7	W
Тѕтс	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C
Reja	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W



## AElectrical Characteristics (T\_J=25 °C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Chara	acteristic				I	
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	60	-	-	V
IDSS	Zero Gate Voltage Drain Current	$V_{DS}$ =60V, $V_{GS}$ = 0V,	-	-	1.0	μA
lgss	Gate to Body Leakage Current	$V_{DS}=0V, V_{GS} = \pm 20V$	-	-	±100	μA
On Chara	acteristics					
$V_{\text{GS(th)}}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	1.0	1.6	2.5	V
	Static Drain-Source on-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =5A	-	31	40	
$R_{DS(on)}$		V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A	-	36	50	mΩ
Dynamic	Characteristics					
Ciss	Input Capacitance		-	1148	-	pF
Coss	Output Capacitance	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz	-	58.5	-	pF
Crss	Reverse Transfer Capacitance		-	49.4	-	pF
Qg	Total Gate Charge	V <sub>DS</sub> =30V, I <sub>D</sub> =2.5A, V <sub>GS</sub> =10V	-	20.3	-	nC
Qgs	Gate-Source Charge		-	3.7	-	nC
$Q_{gd}$	Gate-Drain("Miller") Charge	VGS-10V	-	5.3	-	nC
Switching	g Characteristics					
td(on)	Turn-on Delay Time		-	7.6	-	ns
tr	Turn-on Rise Time	V <sub>DS</sub> =30V, I <sub>D</sub> =5A,	-	20	-	ns
$t_{d(off)}$	Turn-off Delay Time	R <sub>G</sub> =1.8Ω, V <sub>GS</sub> =10V	-	15	-	ns
tr	Turn-off Fall Time		-	24	-	ns
Drain-So	urce Diode Characteristics and	I Maximum Ratings				
ls	Maximum Continuous Drain to Source Diode Forward Current		-	-	5	А
lsм	Maximum Pulsed Drain to Source Diode Forward Current		_	-	20	А
Vsd	Drain to Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =5A	-	-	1.2	V
trr	Body Diode Reverse Recovery Time		-	29	-	ns
Qrr	Body Diode Reverse Recovery Charge	IF=5A, dI/dt=100A/µs	-	43	-	nC

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS condition : T\_J=25  $^\circ C$  ,V\_DD=30V,V\_G=10V,L=0.5mH,Rg=25\Omega,I\_{AS}=8.7A

3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



#### **Typical Performance Characteristics**

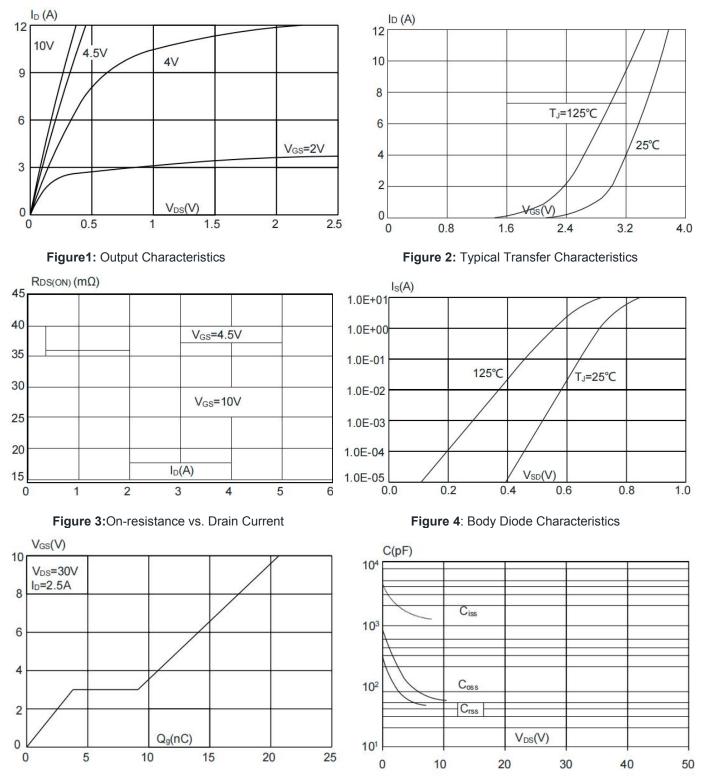
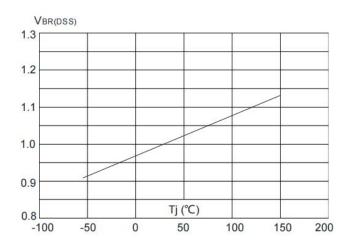


Figure 5: Gate Charge Characteristics

Figure 6: Capacitance Characteristics



# NTTFS5826NL-MS



**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature

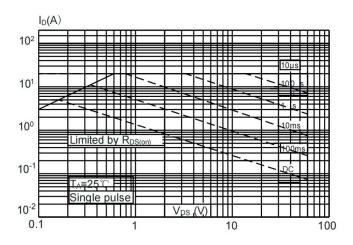


Figure 9: Maximum Safe Operating Area

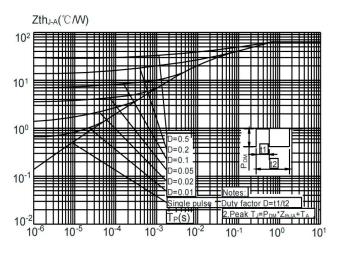
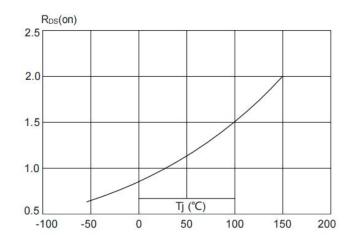
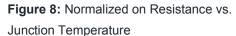
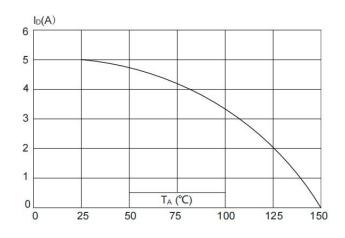


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient







**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature



## **Test Circuit**

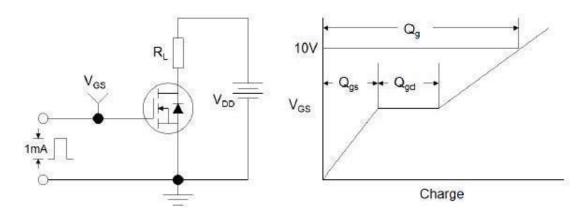


Figure1:Gate Charge Test Circuit & Waveform

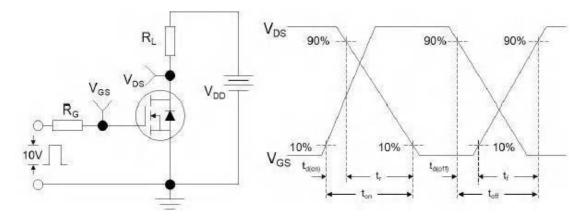


Figure 2: Resistive Switching Test Circuit & Waveforms

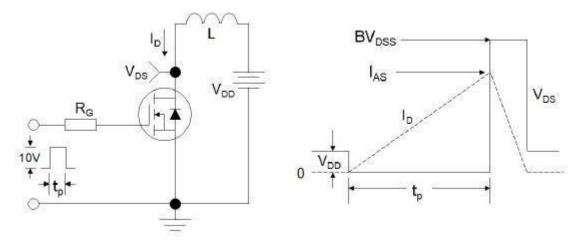
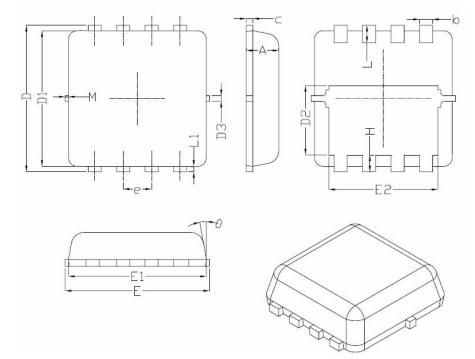


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms



# DFN3X3-8L Package Information



Symphol	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
с	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	_	0.13	-	
Е	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
e	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	_	0.13	-	
М	*	*	0.15	
θ		10 <sup>°</sup>	12 <sup>°</sup>	

#### **REEL SPECIFICATION**

P/N	PKG	QTY
NTTFS5826NL-MS	DFN3X3-8L	5000



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